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S1	553	(330/279).CCLS.	US-PGPUB; USPAT; USOCR	OR	OFF	2005/07/10 09:53
S2	636	(330/285).CCLS.	US-PGPUB; USPAT; USOCR	OR	OFF	2005/07/01 12:28
S3	865	(330/296).CCLS.	US-PGPUB; USPAT; USOCR	OR	OFF	2005/07/01 12:28
S4	832	(330/129).CCLS.	US-PGPUB; USPAT; USOCR	OR	OFF	2005/07/01 12:28
S5	884	(455/126).CCLS.	US-PGPUB; USPAT; USOCR	OR	OFF	2005/07/01 12:28
S6	494	(455/232.1).CCLS.	US-PGPUB; USPAT; USOCR	OR	OFF	2005/07/01 12:31
S9	387	(330/278).CCLS.	US-PGPUB; USPAT; USOCR	OR	OFF	2005/07/01 12:46
S16	576	(330/297).CCLS.	US-PGPUB; USPAT; USOCR	OR	OFF	2005/07/01 13:03
S21	12	amplifier and detect\$3 and ((current near1 voltage) near1 conver\$5) and bias\$3 and capacit\$5 and (resistor or resistive or resistance)	EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/18 11:45
S24	150	amplifier and detect\$3 and ((current near1 voltage) near1 conver\$5) and bias\$3 and "330"/\$. ccls. and @ad<="20030422"	US-PGPUB; USPAT; USOCR	OR	ON	2005/11/18 11:50
S31	554	amplifier and (detect\$3 same ((current near1 voltage) near1 conver\$5)) and bias\$3 and feedback	US-PGPUB; USPAT; USOCR	OR	ON	2005/11/18 11:51

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IEEE JNL IEEE Journal or Magazine

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IEEE CNF IEEE Conference Proceeding

IEE CNF IEE Conference Proceeding

IEEE STD IEEE Standard

**1. 60% efficient 10-GHz power amplifier with dynamic drain bias control**

Narisi Wang; Yousefzadeh, V.; Maksimovic, D.; Pajic, S.; Popovic, Z.B.;  
Microwave Theory and Techniques, IEEE Transactions on  
Volume 52, Issue 3, March 2004 Page(s):1077 - 1081  
Digital Object Identifier 10.1109/TMTT.2004.823592

[AbstractPlus](#) | [References](#) | [Full Text: PDF\(240 KB\)](#) IEEE JNL**2. Automated bias control (ABC) circuit for high-performance VLSIs**

Kuroda, T.; Fukunaga, T.; Matsuo, K.; Kasai, K.; Hirata, A.; Fujii, S.; Kimura, M.; Suzuki, H.;  
Solid-State Circuits, IEEE Journal of  
Volume 27, Issue 4, April 1992 Page(s):641 - 648  
Digital Object Identifier 10.1109/4.126555

[AbstractPlus](#) | [Full Text: PDF\(784 KB\)](#) IEEE JNL**3. Recent Developments in Millimeter Wave Components**

Cohn, M.; Dickens, L.E.; Dozier, J.W.;  
Microwave Symposium Digest, G-MTT International  
Volume 69, Issue 1, May 1969 Page(s):225 - 231

[AbstractPlus](#) | [Full Text: PDF\(816 KB\)](#) IEEE CNF**4. Mobility-lifetime product of CdTe/CdZnTe crystals from charge collection efficiency of X-ray**

Ruzin, A.; Gorelik, J.; Nemirovsky, Y.;  
Electrical and Electronics Engineers in Israel; 1995., Eighteenth Convention of  
7-8 March 1995 Page(s):  
Digital Object Identifier 10.1109/EEIS.1995.513837

[AbstractPlus](#) | [Full Text: PDF\(224 KB\)](#) IEEE CNF**5. Single-photon-counting hotspot detector with integrated RSFQ readout electronics**

Gupta, D.; Kadin, A.M.;  
Applied Superconductivity, IEEE Transactions on  
Volume 9, Issue 2, Part 3, June 1999 Page(s):4487 - 4490  
Digital Object Identifier 10.1109/77.784022

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O'Connor, P.; Gramegna, G.; Rehak, P.; Corsi, F.; Marzocca, C.;  
Nuclear Science, IEEE Transactions on

Volume 44, Issue 3, Part 1, June 1997 Page(s):318 - 325

Digital Object Identifier 10.1109/23.603663

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